EB13C5G1H-24.000M

Mechanical Shock

Solderability

Vibration

Resistance to Soldering Heat

Resistance to Solvents

Temperature Cycling



Series -RoHS Compliant (Pb-free) Low Current 3.3V 4 Pad 3.2mm x 5mm Ceramic SMD LVCMOS Oscillator

Frequency Tolerance/Stability ±100ppm over -40°C to +85°C

Duty Cycle -50 ±10%

MIL-STD-202, Method 213, Condition C

MIL-STD-883, Method 2007, Condition A

MIL-STD-202, Method 210

MIL-STD-202, Method 215

MIL-STD-883, Method 2003

MIL-STD-883, MEthod 1010

EB13C5 G 1 H -24.000M Nominal Frequency

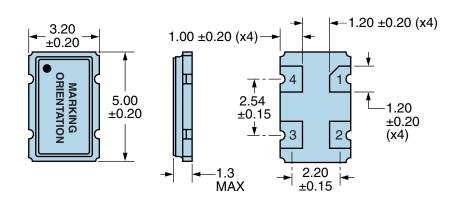
24.000MHz Logic Control / Additional Output Tri-State

TIONS
24.000MHz
±100ppm over -40°C to +85°C (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Ouput Load Change, First Year Aging at 25°C, Shock, and Vibration)
3.3Vdc ±10%
3mA Maximum
90% of Vdd Minimum
-1.6mA
10% of Vdd Maximum
+1.6mA
6nSec Maximum (Measured at 20% to 80% of waveform)
50 ±10% (Measured at 50% of waveform)
15pF Maximum
CMOS
Tri-State
90% of Vdd Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output (High Impedance)
10µA Maximum (Disabled Output: High Impedance)
25pSec Maximum
10 mSec Maximum
-55°C to +125°C
HANICAL SPECIFICATIONS
MIL-STD-883, Method 1014, Condition A
MIL-STD-883, Method 1014, Condition C

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www.ecliptek.com	Specification S	ubject to Change	e Without Notice	Rev A 8/12/2010	Page 1 of 5

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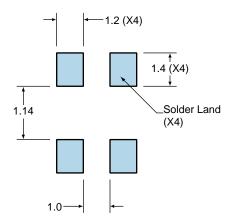
MECHANICAL DIMENSIONS (all dimensions in millimeters)



PIN	CONNECTION
1	Tri-State
2	Ground
3	Output
4	Supply Voltage
LINE	MARKING
LINE 1	MARKING E24.000 E=Ecliptek Designator

Suggested Solder Pad Layout

All Dimensions in Millimeters



All Tolerances are ±0.1



EB13C5G1H-24.000M



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output



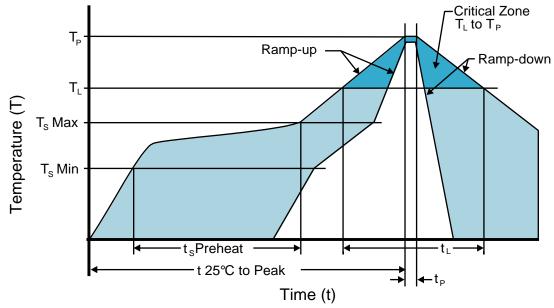
Note 1: An external 0.1μ F low frequency tantalum bypass capacitor in parallel with a 0.01μ F high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value \dot{C}_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

EB13C5G1H-24.000M

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T _s MAX to T _L (Ramp-up Rate)	3°C/second Maximum
Preheat	
 Temperature Minimum (T_s MIN) 	150°C
 Temperature Typical (T_s TYP) 	175°C
 Temperature Maximum (T_s MAX) 	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T⊾ to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (t _p)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1



Recommended Solder Reflow Methods

EB13C5G1H-24.000M



Low Temperature Infrared/Convection 240°C

T _s MAX to T _L (Ramp-up Rate)	5°C/second Maximum	
Preheat		
- Temperature Minimum (T _s MIN)	N/A	
- Temperature Typical (T _s TYP)	150°C	
- Temperature Maximum (T _s MAX)	N/A	
- Time (t _s MIN)	60 - 120 Seconds	
Ramp-up Rate (T _L to T _P)	5°C/second Maximum	
Time Maintained Above:		
- Temperature (T _L)	150°C	
- Time (t∟)	200 Seconds Maximum	
Peak Temperature (T _P)	240°C Maximum	
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times	
Time within 5°C of actual peak (t _p)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time	
Ramp-down Rate	5°C/second Maximum	
Time 25°C to Peak Temperature (t)	N/A	
Moisture Sensitivity Level	Level 1	

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.